Cyber-Security in Smart Cities: Latest Advances and Prospects

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Deadline for manuscript submissions:
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Message from the Guest Editors

We would particularly like to invite submissions of the latest advances and prospects of cyber-security in smart cities that have received little or no attention to date. We would also like to encourage submissions that use immersive technology such as augmented or virtual reality, quantum computing, post-quantum cryptosystem, zero-trust architecture, artificial intelligence, etc.

Topics in this Special Issue of *Smart Cities* include, but are not limited to, the following:

- Smart city;
- 5G/6G;
- Internet of Things/Vehicle;
- Medical information;
- Transportation;
- Wireless communication;
- Blockchain technology;
- Governance;
- Electronic grid;
- Security and privacy;
- Security mechanisms.

Special Issue

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Message from the Editor-in-Chief

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